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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/068,276	02/06/2002	Chen-Yueh Kung	JCLA8191	9729

7590
J.C. Patents, Inc.
4 Venture, Suite 250
Irvine, CA 92618

05/06/2003

EXAMINER

PAREKH, NITIN

ART UNIT	PAPER NUMBER
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2811

DATE MAILED: 05/06/2003

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Applicati n No.

10/068,276

Applicant(s)

KUNG ET AL.

Examiner

Nitin Parekh

Art Unit

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondenc address --
Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 11 February 2002.
- 2a) ☐ This action is FINAL. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-13 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-13 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 06 February 2002 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- 11) ☐ The proposed drawing correction filed on _____ is: a) ☐ approved b) ☐ disapproved by the Examiner.
If approved, corrected drawings are required in reply to this Office action.
- 12) ☐ The oath or declaration is objected to by the Examiner.

Priority under 35 U.S.C. §§ 119 and 120

- 13) ☒ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☒ All b) ☐ Some * c) ☐ None of:
1. ☒ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. _____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.
- 14) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).
- a) ☐ The translation of the foreign language provisional application has been received.
- 15) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.

Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☐ Information Disclosure Statement(s) (PTO-1449) Paper No(s) _____
- 4) ☐ Interview Summary (PTO-413) Paper No(s). _____
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: _____

DETAILED ACTION

Election/Restriction

1. Applicant's election without traverse of Group I, claims 1-13 in Paper No. 4 is acknowledged.

Oath/Declaration

2. The oath/declaration filed on 02/06/02 is acceptable.

Drawings

3. The formal drawings filed on 02/06/02 are acceptable.

Priority

4. Receipt is acknowledged of papers submitted under 35 U.S.C. 119(a)-(d), which papers have been placed of record in the file.

Information Disclosure Statement

5. If applicant is aware of any relevant prior art, he/she requested to cite it on form PTO-1449 in accordance with the guidelines set forth in M.P.E.P. 609.

Claim Rejections - 35 USC § 103

6. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

7. Claims 1-10 are rejected under 35 U.S.C. 103(a) as being unpatentable over Brooks et al. (US Pat. 6084297) in view of Schueller (US Pat. 5866949).

Regarding claim 1, Brooks et al. disclose a tape ball grid array (TBGA) package comprising:

- a dielectric layer (16/18 in Fig. 2) having a first/top side and a second/bottom side and a plurality of via holes (34 in Fig. 2) that pass through the dielectric layer
- a patterned first metallic layer (22 in Fig. 2) over the first side of the dielectric layer such that on end of the via holes is closed to form a plurality of blind holes (34 in Fig. 2)
- a patterned second metallic layer (20/24 in Fig. 2) over the second side of the dielectric layer, the second metallic layer including conductive contact element site/pad (24 in Fig. 2) connecting the respective via holes and serving as a

- ground, power or reference/signal transmission plane/layer depending on application requirements (Col. 7, line 1-5)
- a patterned first solder mask layer (8 in Fig. 2) over the first metallic layer exposing a portion of the metallic layer to serve as a plurality of contact points and conductive traces/paths (46 and 32 in Fig. 1 and 2; Col. 5, line 65- Col. 6, line 35)
 - a patterned second solder mask layer (6 in Fig. 2) over the second metallic layer exposing a portion of the metallic layer and conductive element sites (Col. 6, line 2)
 - a plurality of conductive elements/solder balls (26 in Fig. 2) being placed on the conductive element sites at the blind holes with one end protruding out from the surface of the second solder mask (Col. 5, line 40; Col. 6, line 10-16)
 - the solder balls, the first metallic layer and the second metallic layers being electrically connected (Fig. 2; Col. 5, line 25-65), and
 - a chip having an active/top surface including a plurality of bonding pads (14a in Fig. 2) and a back surface, the chip being electrically connected to various inner pads/contact points (46 in Fig. 2) on the first/top side of the tape (Fig. 1 and 2; Col. 5, line 15- Col. 7, line 25).

Brooks et al. fail to teach the blind via holes having an open end such that the solder balls are inserted into the blind via holes.

Schueller teaches a flexible BGA package having via holes/blind vias and solder balls where the via hole (55 in Fig. 3B) has an open end (see the end at pad 59b in Fig. 3B) such that the solder balls (54a in Fig. 3B) are inserted into the blind via holes at the open end to provide the desired ground connection (Col. 9, line 25-33).

It would have been obvious to a person of ordinary skill in the art at the time the invention was made to incorporate the blind via holes having an open end such that the solder balls are inserted into the blind via holes as taught by Schueller so that the desired ground, power or signal routing can be achieved and the thermal dissipation can be improved in Brooks et al's package.

Regarding claim 2, Brooks et al. teach the dielectric layer (16/18 in Fig. 2) including polyimide material (Col. 5, line 26).

Regarding claim 3, Brooks et al. teach the second metallic layer (20/24 in Fig. 2) serving as ground or power plane/layer (Col. 7, line 1-5).

Regarding claim 4, Brooks et al. teach the second metallic layer (24/20 in Fig. 2) serving as ground, power or reference/signal transmission plane/layer depending on application requirements (Col. 7, line 1-5).

Regarding claim 5, Brooks et al. teach the material of the first and second metallic layers (22 and 24/20 respectively in Fig. 2) constituting copper material (Col. 5, line 28).

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Regarding claim 6, Brooks et al. teach the first and second metallic layers (22 and 24/20 respectively in Fig. 2) further including metallic alloy layers (Col. 5, line 53).

Regarding claim 7, Brooks et al. teach the first and second metallic layers (22 and 24/20 respectively in Fig. 2) constituting the nickel-gold alloy material (Col. 5, line 53).

Regarding claim 8, Brooks et al. teach the chip having the plurality of bonding pads on the active surface (14a in Fig. 2; Col. 7, line 11).

Regarding claim 9, Brooks et al. teach the package further including:

- a plurality of conductive wires and packaging material (48 and 54 respectively in Fig. 2)
- the back side of the chip being attached using a dielectric adhesive (Col. 6, line 58)
- the conductive wires connecting the bonding pads and corresponding contact points on the tape (48/14a/46 in Fig. 1 and 2), and
- the packaging material (54 in Fig. 2) enclosing the chip, conductive wires and contact points

(Col. 6, line 53- Col. 7, line 25).

Brooks et al. fail to teach the chip being attached to the first solder mask layer.

Schueller teaches using a dielectric adhesive such as polyimide/solder mask (64 in Fig. 3B) as a chip attachment material to reduce the stress and to improve reliability of solder joints (Col. 8, line 57; Col. 9, line 65- Col. 10, line 11).

It would have been obvious to a person of ordinary skill in the art at the time the invention was made to incorporate the chip being attached to the first solder mask layer as taught by Schueller so that the chip adhesion and the reliability of the bonding /interconnection can be improved in Brooks et al's package.

Regarding claim 10, Brooks et al. teach using a composite adhesive/heat sink/stiffener frame (40/50 in Fig. 2) on the first solder mask surrounding the packaging material and the chip (Col. 6, line 17-52).

7. Claims 11-13 are rejected under 35 U.S.C. 103(a) as being unpatentable over Brooks et al. (US Pat. 6084297) and Schueller (US Pat. 5866949) as applied to claims 1 and 8 above, and further in view of Dordi (US Pat. 5835355).

Regarding claim 11, Brooks et al. and Schueller teach substantially the entire claimed structure, as applied to claims 1 and 8 above, except a plurality of bumps protruding from the bonding pads and the bumps correspond in position to various contact points.

Dordi teaches using a TBGA package where an active surface/bottom of a chip (12 in Fig. 1) has a plurality of interconnection points comprising pads (not numerically referenced in Fig. 1; Col. 4, line 46) and bonding bumps (14 in Fig. 1) protruding from the respective interconnection points corresponding in position to various/selected traces/contact points (Col. 4, lines 45-60).

It would have been obvious to a person of ordinary skill in the art at the time the invention was made to incorporate the plurality of bumps protruding from the bonding pads and the bumps corresponding in position to various contact points chip as taught

by Dordi so that the package height can be reduced and the reliability of the bonding /interconnection can be improved in Brooks et al. and Schueller's package.

Regarding claim 12, Brooks et al. and Schueller teach substantially the entire claimed structure, as applied to claims 1, 8 and 11 above, except an underfilling material enclosing the bonding pads, the bumps and the contact points.

Dordi teaches using the TBGA package having an encapsulant/underfill (13 in Fig. 1) sealing the bonding pads, the bumps and the respective contact points (Col. 5, line 15).

It would have been obvious to a person of ordinary skill in the art at the time the invention was made to incorporate an underfilling material enclosing the bonding pads, the bumps and the contact points as taught by Dordi so that the surface protection at the interconnection points can be improved and the reliability of the bonding /interconnection can be improved in Brooks et al. and Schueller's package.

Regarding claim 13, Brooks et al. and Schueller teach substantially the entire claimed structure, as applied to claims 1, 8, 10 and 11 above, including the stiffener (40/50 in Fig. 2) on the first solder mask surrounding the chip (Col. 6, line 17-52).

Conclusion

8. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Reference D is cited as being related to a flexible BGA package.

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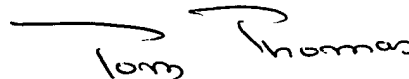
Any inquiry concerning this communication or earlier communications from the examiner should be directed to Nitin Parekh whose telephone number is 703-305-3410. The examiner can normally be reached on 09:00AM-05:30PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Tom Thomas can be reached on 703-308-2772. The fax phone numbers for the organization where this application or proceeding is assigned are 703-308-7722, 703-308-7724 or 703-872-9318 (Right FAX) for regular communications; 703-872-9310 (Right FAX) for After Final communications and 703-872-9310 (Right FAX) for customer service.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-306-3431.

Nitin Parekh

NP
03-29-03

A handwritten signature in black ink that reads "Tom Thomas". The signature is stylized, with a long horizontal line for the "T" and a cursive "Thomas" following it.

TOM THOMAS
SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 2800